

# Andrew D Koehler

## List of Publications by Year in descending order

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23  
papers

1,331  
citations

933447

10  
h-index

794594

19  
g-index

23  
all docs

23  
docs citations

23  
times ranked

1808  
citing authors

#	ARTICLE	IF	CITATIONS
1	Effect of GaN Substrate Properties on Vertical GaN PiN Diode Electrical Performance. Journal of Electronic Materials, 2021, 50, 3013-3021.	2.2	8
2	A Study on the Impact of Mid-Gap Defects on Vertical GaN Diodes. IEEE Transactions on Semiconductor Manufacturing, 2020, 33, 546-551.	1.7	5
3	Reduced Contact Resistance in GaN Using Selective Area Si Ion Implantation. IEEE Transactions on Semiconductor Manufacturing, 2019, 32, 478-482.	1.7	3
4	The Effect of the Gate-Connected Field Plate on Single-Event Transients in AlGaIn/GaN Schottky-Gate HEMTs. IEEE Transactions on Nuclear Science, 2019, 66, 1682-1687.	2.0	10
5	GaN-On-Diamond HEMT Technology With $T_{AVG} = 176^{\circ}\text{C}$ at $P_{DC,max} = 56 \text{ W/mm}$ Measured by Transient Thermoreflectance Imaging. IEEE Electron Device Letters, 2019, 40, 881-884.	3.9	52
6	Investigation of Single-Event Transients in AlGaIn/GaN MIS-Gate HEMTs Using a Focused X-Ray Beam. IEEE Transactions on Nuclear Science, 2019, 66, 368-375.	2.0	9
7	Vertical power devices enabled by bulk GaN substrates. , 2019, , .		1
8	Correlation of the Spatial Variation of Single-Event Transient Sensitivity With Thermoreflectance Thermography in $\text{Al}_x\text{Ga}_{1-x}\text{N}/\text{GaN}$ HEMTs. IEEE Transactions on Nuclear Science, 2018, 65, 369-375.	2.0	6
9	Ultrawide-Bandgap Semiconductors: Research Opportunities and Challenges. Advanced Electronic Materials, 2018, 4, 1600501.	5.1	839
10	High resistivity halide vapor phase homoepitaxial $\text{In}^2\text{-Ga}_2\text{O}_3$ films co-doped by silicon and nitrogen. Applied Physics Letters, 2018, 113, .	3.3	30
11	Electrothermal Evaluation of AlGaIn/GaN Membrane High Electron Mobility Transistors by Transient Thermoreflectance. IEEE Journal of the Electron Devices Society, 2018, 6, 922-930.	2.1	14
12	A Tri-Layer PECVD SiN Passivation Process for Improved AlGaIn/GaN HEMT Performance. ECS Journal of Solid State Science and Technology, 2017, 6, P58-P61.	1.8	10
13	Application of a Focused, Pulsed X-Ray Beam to the Investigation of Single-Event Transients in $\text{Al}_{0.3}\text{Ga}_{0.7}\text{N}/\text{GaN}$ HEMTs. IEEE Transactions on Nuclear Science, 2017, 64, 97-105.	2.0	9
14	Vertical GaN Junction Barrier Schottky Diodes. ECS Journal of Solid State Science and Technology, 2017, 6, Q10-Q12.	1.8	33
15	High Voltage GaN Lateral Photoconductive Semiconductor Switches. ECS Journal of Solid State Science and Technology, 2017, 6, S3099-S3102.	1.8	12
16	Vertical GaN Junction Barrier Schottky Rectifiers by Selective Ion Implantation. IEEE Electron Device Letters, 2017, 38, 1097-1100.	3.9	136
17	Spatial Mapping of Pristine and Irradiated AlGaIn/GaN HEMTs With UV Single-Photon Absorption Single-Event Transient Technique. IEEE Transactions on Nuclear Science, 2016, 63, 1995-2001.	2.0	20
18	Hyperspectral Electroluminescence Characterization of OFF-State Device Characteristics in Proton Irradiated High Voltage AlGaIn/GaN HEMTs. ECS Journal of Solid State Science and Technology, 2016, 5, Q289-Q293.	1.8	11

#	ARTICLE	IF	CITATIONS
19	Vertical GaN junction barrier schottky diodes by Mg implantation and activation annealing. , 2016, , .		0
20	A Comparison of Single-Event Transients in Pristine and Irradiated $\text{Al}_{0.3}\text{Ga}_{0.7}\text{N}/\text{m GaN}$ HEMTs using Two-Photon Absorption and Heavy Ions. IEEE Transactions on Nuclear Science, 2015, 62, 2743-2751.	2.0	22
21	Degradation mechanisms of AlGaIn/GaN HEMTs on sapphire, Si, and SiC substrates under proton irradiation. , 2014, , .		9
22	Substrate-Dependent Effects on the Response of AlGaIn/GaN HEMTs to 2-MeV Proton Irradiation. IEEE Electron Device Letters, 2014, 35, 826-828.	3.9	78
23	Degradation of dynamic ON-resistance of AlGaIn/GaN HEMTs under proton irradiation. , 2013, , .		14